Form PTO 1449		U.S. DEPARTMENT	OF COMMERCE	ATTY DOCKET NO.		SERIAL NO.		
(Modified)		PATENT AND TRA	DEMARK OFFICE	281752US2PCT _		10/559,665		
				APPLICANT				
LIST OF	REFE	RENCES CITED BY AF	PPLICANT	Kohji KANBARA, et al.				
				FILING DATE		GROUP		
				December 5, 2005		2446 -		
U.S. PATENT DOCUMENTS								
EXAMINER		DOCUMENT	DATE	NAME	CLASS	SUB	FILING DATE	
INITIAL		NUMBER				CLASS	IF APPROPRIATE	
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FOREIGN PATENT DOCUMENTS								
		DOCUMENT NUMBER	DATE	COUNTRY		TRANSLATION		
	40	2003-99655	04/04/2003	JAPAN (with English Abstract)		YES	S NO X	
	AO AP	2003-99655	05/23/2003	JAPAN (with English Abstract)				
	AQ	2003-130829	03/29/2002	JAPAN (with English Abstract)				
	AR	2002-92400	02/08/2002	JAPAN (with English Abstract)			×	
	AS	2002-41973	11/02/2001	JAPAN (with English Abstract)		-	×	
	AT	8-147374	06/07/1996	JAPAN (with English Abstract)	.		×	
	AU	2000-194750	07/14/2000	JAPAN (with English Abstract)				
	AV	2000-194730	0771472000	JAF AN (WITH ETIGISTI Abstract)			X	
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)								
	AW							
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	AZ ——						erences sheet(s) attached	
Examiner					Date Considered			
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.								